

**Search Notes**

Application/Control No.

10/522,178

Examiner

Brian Nash

Applicant(s)/Patent under  
Reexamination

SHIMIZU ET AL.

Art Unit

3721

**SEARCHED**

Class	Subclass	Date	Examiner
227	155,119, 120,124, 134,135, 139	3/1/2006	BN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
227	US PGPub	7/17/2006	BN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
227 (patents only) text, IDS, invntr - via EAST - updated 7/17/2006	7/17/2006	BN